Notice of References Cited Application/Control No. 10/805,023 Examiner Tan Dean D. Nguyen Applicant(s)/Patent Under Reexamination IKEDA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,651,191	11-2003	Vacante et al.	714/47 .
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		·	
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-	9,00,000,000,000		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			72.2 - 1 150		
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
!	٦	
	>	
	>	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.